

BLF6G27-45; BLF6G27S-45

WiMAX power LDMOS transistor

Rev. 4 — 7 March 2013

Product data sheet

1. Product profile

1.1 General description

45 W LDMOS power transistor for base station applications at frequencies from 2500 MHz to 2700 MHz.

Table 1. Typical performance

RF performance at $T_{case} = 25\text{ °C}$ in a class-AB production test circuit.

Mode of operation	f (MHz)	V _{DS} (V)	P _{L(AV)} (W)	G _p (dB)	η _D (%)	ACPR _{885k} (dBc)	ACPR _{1980k} (dBc)
1-carrier N-CDMA ^[1]	2500 to 2700	28	7	18	24	-49 ^[2]	-64 ^[2]

[1] Single carrier N-CDMA with pilot, paging sync and 6 traffic channels (Walsh codes 8 - 13). PAR = 9.7 dB at 0.01 % probability on CCDF. Channel bandwidth is 1.23 MHz.

[2] Measured within 30 kHz bandwidth.

CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Therefore care should be taken during transport and handling.

1.2 Features and benefits

- Typical 1-carrier N-CDMA performance (single carrier N-CDMA with pilot, paging, sync and 6 traffic channels [Walsh codes 8 - 13]. PAR = 9.7 dB at 0.01 % probability on CCDF. Channel bandwidth is 1.23 MHz), a supply voltage of 28 V and an I_{DQ} of 350 mA:
- Qualified up to a maximum V_{DS} operation of 32 V
- Integrated ESD protection
- Excellent ruggedness
- High efficiency
- Excellent thermal stability
- Designed for broadband operation
- Internally matched for ease of use
- Low gold plating thickness on leads
- Compliant to Directive 2002/95/EC, regarding Restriction of Hazardous Substances (RoHS)

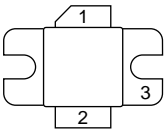

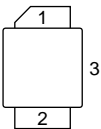



1.3 Applications

- RF power amplifiers for base stations and multi carrier applications in the 2500 MHz to 2700 MHz frequency range

2. Pinning information

Table 2. Pinning

Pin	Description	Simplified outline	Graphic symbol
BLF6G27-45 (SOT608A)			
1	drain		
2	gate		
3	source		
BLF6G27S-45 (SOT608B)			
1	drain		
2	gate		
3	source		

[1] Connected to flange.

3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
BLF6G27-45	-	flanged ceramic package; 2 mounting holes; 2 leads	SOT608A
BLF6G27S-45	-	ceramic earless flanged package; 2 leads	SOT608B

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage		-	65	V
V_{GS}	gate-source voltage		-0.5	+13	V
I_D	drain current		-	20	A
T_{stg}	storage temperature		-65	+150	°C
T_j	junction temperature		-	200	°C

5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Type	Typ	Unit
$R_{th(j-case)}$	thermal resistance from junction to case	$T_{case} = 80\text{ }^{\circ}\text{C}$; $P_L = 34\text{ W (CW)}$	BLF6G27-45	1.7	K/W
			BLF6G27S-45	1.7	K/W

6. Characteristics

Table 6. Characteristics

$T_j = 25\text{ }^{\circ}\text{C}$ per section; unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$V_{(BR)DSS}$	drain-source breakdown voltage	$V_{GS} = 0\text{ V}$; $I_D = 0.5\text{ mA}$	65	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$V_{DS} = 10\text{ V}$; $I_D = 60\text{ mA}$	1.4	1.9	2.4	V
I_{DSS}	drain leakage current	$V_{GS} = 0\text{ V}$; $V_{DS} = 28\text{ V}$	-	-	1.4	μA
I_{DSX}	drain cut-off current	$V_{GS} = V_{GS(th)} + 3.75\text{ V}$; $V_{DS} = 10\text{ V}$	8.8	10.4	-	A
I_{GSS}	gate leakage current	$V_{GS} = 11\text{ V}$; $V_{DS} = 0\text{ V}$	-	-	140	nA
g_{fs}	forward transconductance	$V_{DS} = 10\text{ V}$; $I_D = 2.5\text{ A}$	-	4.3	-	S
$R_{DS(on)}$	drain-source on-state resistance	$V_{GS} = V_{GS(th)} + 3.75\text{ V}$; $I_D = 2.1\text{ A}$	-	0.24	0.385	Ω
C_{rs}	feedback capacitance	$V_{GS} = 0\text{ V}$; $V_{DS} = 28\text{ V}$; $f = 1\text{ MHz}$	-	1.1	-	pF

7. Application information

Table 7. Application information

Mode of operation: Single carrier N-CDMA with pilot, paging, sync and 6 traffic channels (Walsh codes 8 - 13). PAR 9.7 dB at 0.01 % probability on CCDF; channel bandwidth = 1.23 MHz; $f = 2700\text{ MHz}$; RF performance at $V_{DS} = 28\text{ V}$; $I_{Dq} = 350\text{ mA}$; $T_{case} = 25\text{ }^{\circ}\text{C}$; unless otherwise specified; in a class-AB production circuit.

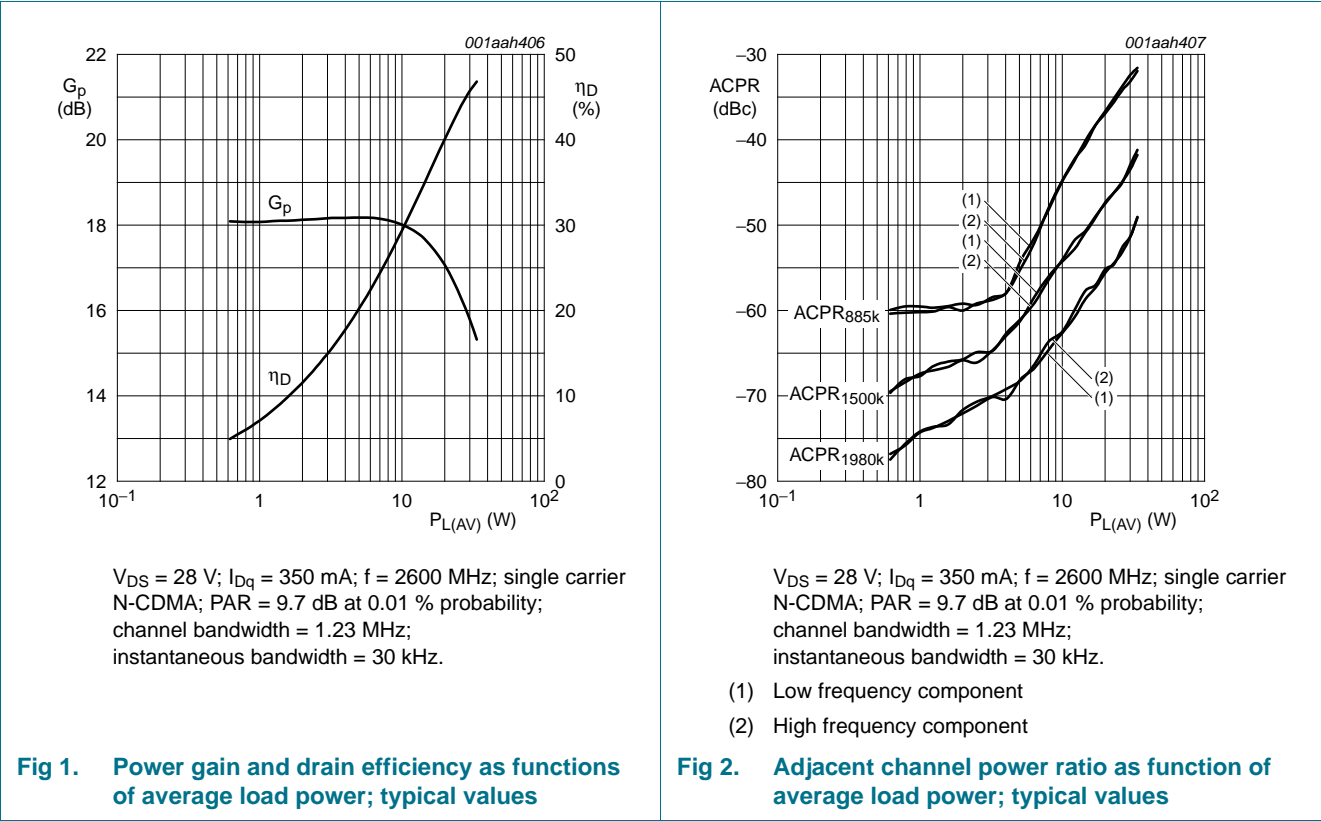
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$P_{L(AV)}$	average output power		-	7	-	W
G_p	power gain	$P_{L(AV)} = 7\text{ W}$	16.5	18	-	dB
RL_{in}	input return loss	$P_{L(AV)} = 7\text{ W}$	-	-10	-5	dB
η_D	drain efficiency	$P_{L(AV)} = 7\text{ W}$	22	24	-	%
$ACPR_{885k}$	adjacent channel power ratio (885 kHz)	$P_{L(AV)} = 7\text{ W}$ [1]	-	-49	-46	dBc
$ACPR_{1980k}$	adjacent channel power ratio (1980 kHz)	$P_{L(AV)} = 7\text{ W}$ [1]	-	-64	-61	dBc

[1] Measured within 30 kHz bandwidth.

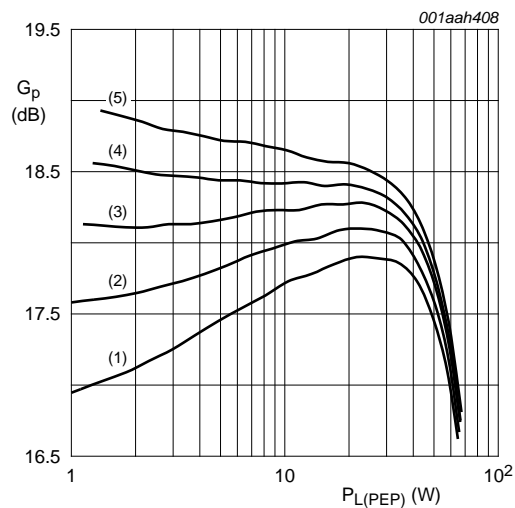
7.1 Ruggedness in class-AB operation

The BLF6G27-45 and BLF6G27S-45 are capable of withstanding a load mismatch corresponding to VSWR = 10 : 1 through all phases under the following conditions: $V_{DS} = 28\text{ V}$; $I_{Dq} = 350\text{ mA}$; $P_L = 45\text{ W (CW)}$; $f = 2600\text{ MHz}$.

7.2 Single carrier N-CDMA performance



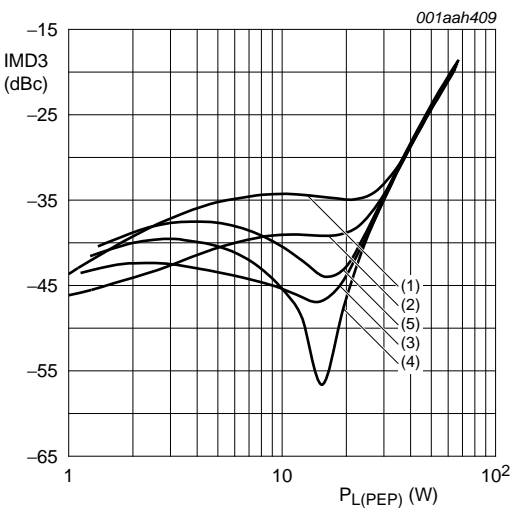
7.3 Two-tone



$V_{DS} = 28\text{ V}$; $f_1 = 2598.75\text{ MHz}$; $f_2 = 2601.25\text{ MHz}$; 2.5 MHz tone spacing.

- (1) $I_{DQ} = 250\text{ mA}$
- (2) $I_{DQ} = 300\text{ mA}$
- (3) $I_{DQ} = 350\text{ mA}$
- (4) $I_{DQ} = 400\text{ mA}$
- (5) $I_{DQ} = 500\text{ mA}$

Fig 3. Power gain as function of peak envelope load power; typical values



$V_{DS} = 28\text{ V}$; $f_1 = 2598.75\text{ MHz}$; $f_2 = 2601.25\text{ MHz}$; 2.5 MHz tone spacing.

- (1) $I_{DQ} = 250\text{ mA}$
- (2) $I_{DQ} = 300\text{ mA}$
- (3) $I_{DQ} = 350\text{ mA}$
- (4) $I_{DQ} = 400\text{ mA}$
- (5) $I_{DQ} = 500\text{ mA}$

Fig 4. Third order intermodulation distortion as function of peak envelope load power; typical values

7.4 Continuous wave

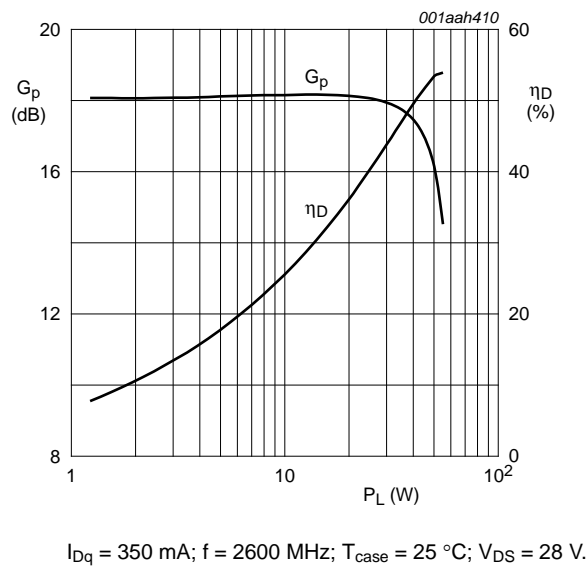


Fig 5. Power gain and drain efficiency as functions of CW load power; typical values

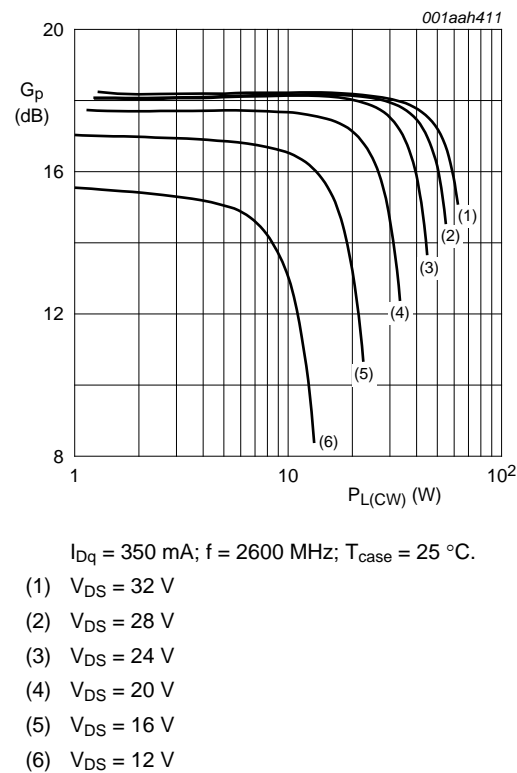
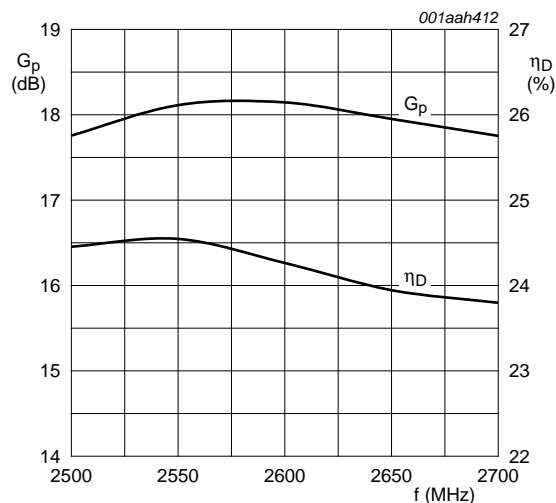


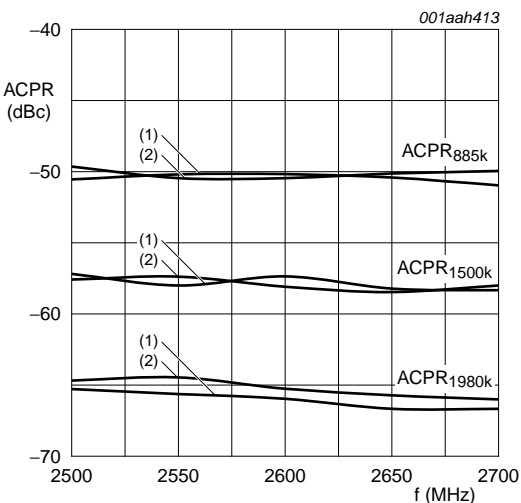
Fig 6. Power gain as function of CW load power; typical values

7.5 Single carrier N-CDMA broadband performance at 7 W average



$V_{DS} = 28$ V; $I_{DQ} = 350$ mA; single carrier N-CDMA;
PAR = 9.7 dB at 0.01 % probability;
instantaneous bandwidth = 30 kHz.

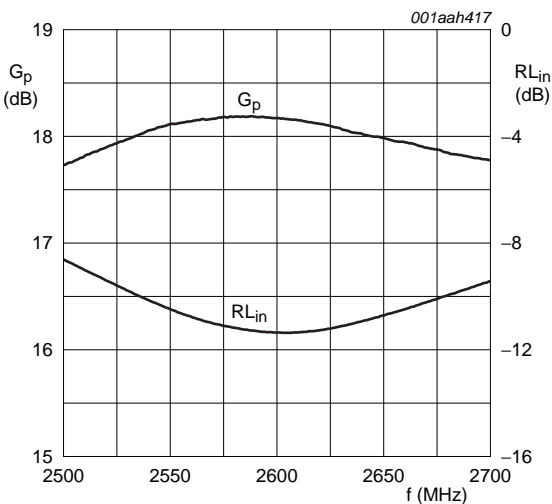
Fig 7. Power gain and drain efficiency as functions of frequency; typical values



$V_{DS} = 28$ V; $I_{DQ} = 350$ mA; single carrier N-CDMA;
PAR = 9.7 dB at 0.01 % probability;
instantaneous bandwidth = 30 kHz.

- (1) Low frequency component
- (2) High frequency component

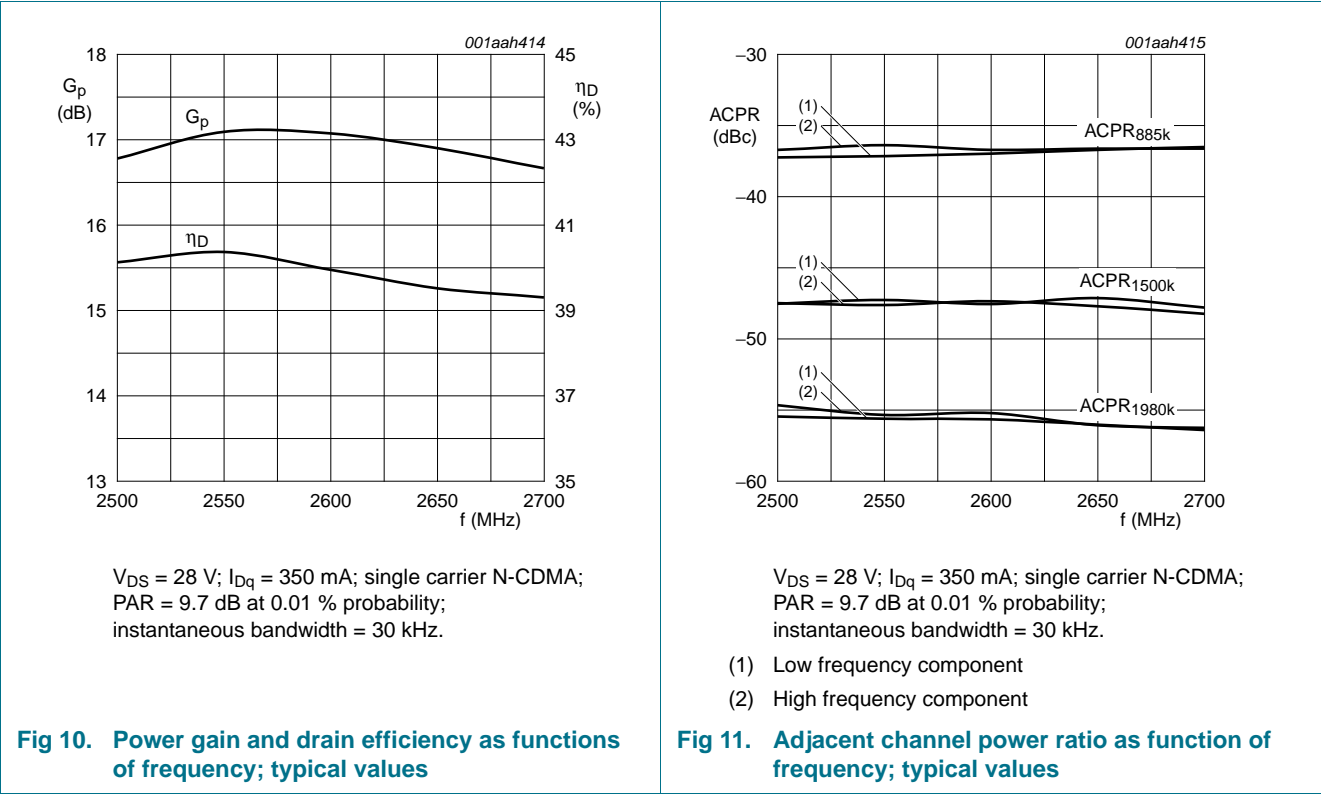
Fig 8. Adjacent channel power ratio as function of frequency; typical values



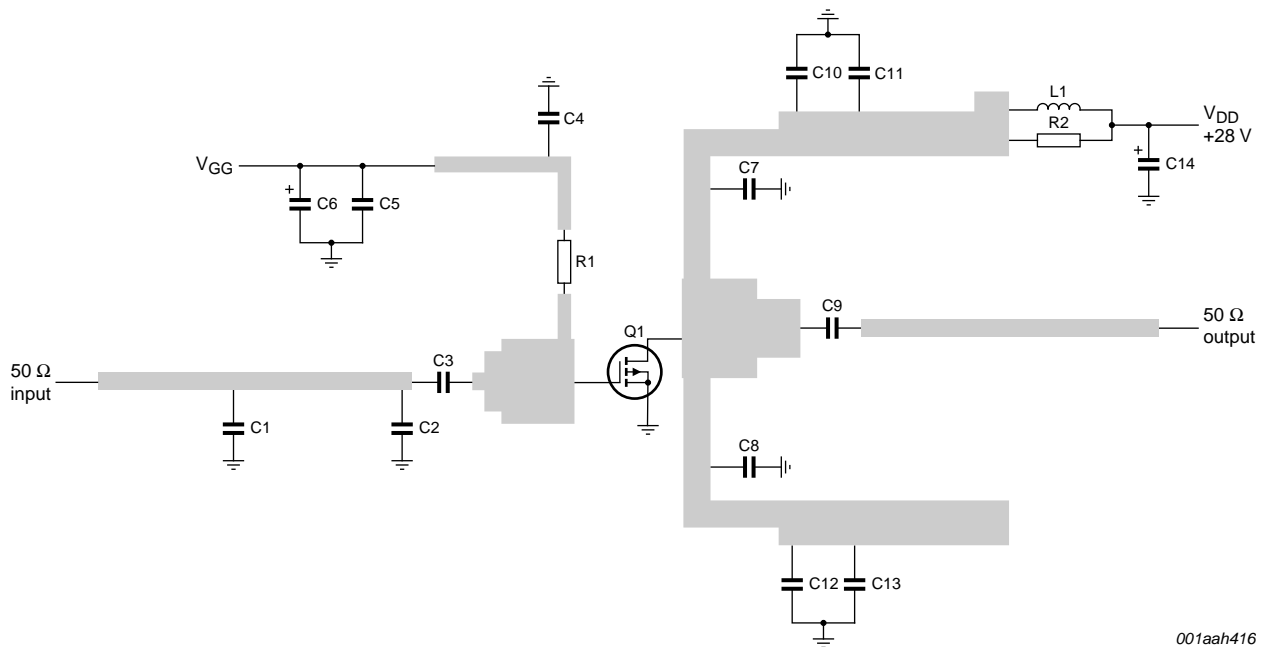
$V_{DS} = 28$ V; $I_{DQ} = 350$ mA; single carrier N-CDMA; PAR = 9.7 dB at 0.01 % probability; instantaneous bandwidth = 30 kHz.

Fig 9. Power gain and input return loss as functions of frequency

7.6 Single carrier N-CDMA broadband performance at 20 W average

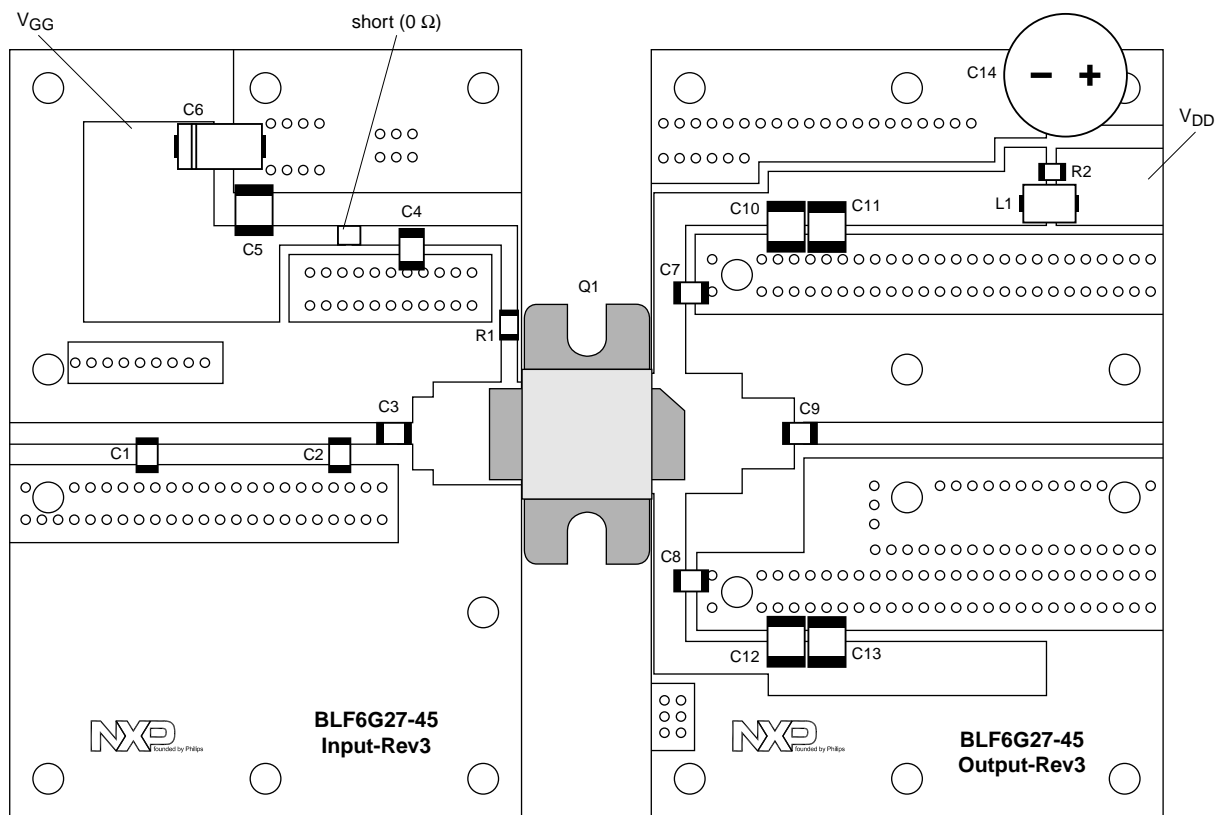


8. Test information



See [Table 8](#) for list of components.

Fig 12. Test circuit for operation at 2500 MHz to 2700 MHz



Striplines are on a double copper-clad Taconic RF35 Printed-Circuit Board (PCB) with $\epsilon_r = 3.5$ and thickness = 0.76 mm.
See [Table 8](#) for list of components.

Fig 13. Component layout for 2500 MHz to 2700 MHz test circuit

Table 8. List of components

For test circuit, see [Figure 12](#) and [Figure 13](#).

Component	Description	Value	Remarks
C1	multilayer ceramic chip capacitor	0.3 pF	[1]
C2	multilayer ceramic chip capacitor	0.5 pF	[1]
C3, C4, C7, C8	multilayer ceramic chip capacitor	11 pF	[1]
C5, C10, C11, C12, C13	multilayer ceramic chip capacitor	4.7 μ F	C4532X7R1H475M
C6	tantalum capacitor	10 μ F; 35 V	Kemet (Farnell)
C9	multilayer ceramic chip capacitor	8.2 pF	
C14	electrolytic capacitor	470 μ F; 63 V	
L1	ferrite SMD bead	-	Ferroxcube BDS 3/3/4.6-4S2 or equivalent
R1	resistor	22 Ω	package 0603
R2	resistor	12 Ω	package 1206
Q1	BLF6G27-45 or BLF6G27S-45	-	

[1] American Technical Ceramics type 100B or capacitor of same quality.

Table 9. Measured test circuit impedances

f (GHz)	Z_i (Ω)	Z_o (Ω)
2.50	11.1 – j11.0	18.4 – j9.1
2.55	10.6 – j10.8	16.9 – j9.2
2.60	10.1 – j10.5	15.6 – j9.2
2.65	9.6 – j10.2	14.4 – j9.1
2.70	9.1 – j9.8	13.3 – j8.9

9. Package outline

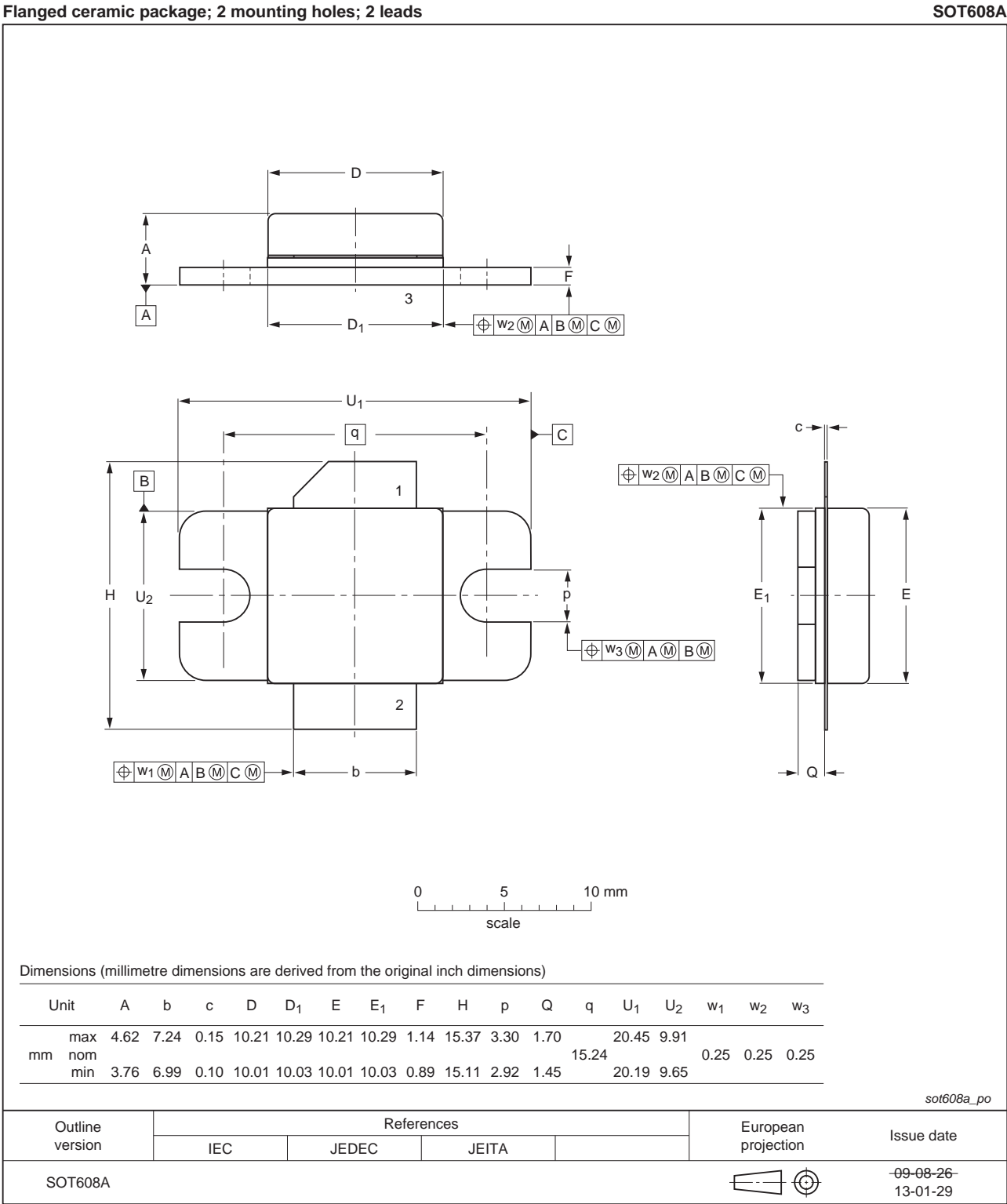
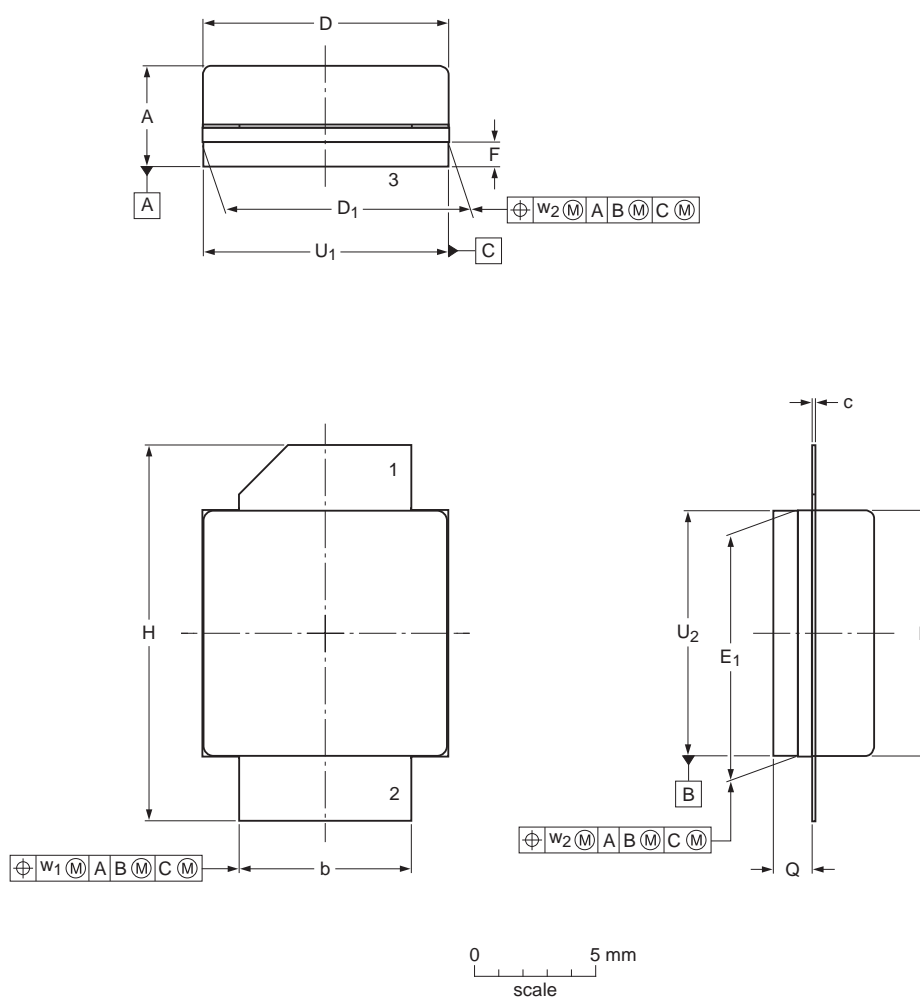


Fig 14. Package outline SOT608A

Ceramic earless flanged package; 2 leads

SOT608B



Dimensions (millimetre dimensions are derived from the original inch dimensions)

Unit		A	b	c	D	D ₁	E	E ₁	F	H	Q	U ₁	U ₂	w ₁	w ₂
mm	max	4.62	7.24	0.15	10.21	10.29	10.21	10.29	1.14	15.37	1.70	10.24	10.24	0.25	0.25
	min	3.76	6.99	0.10	10.01	10.03	10.01	10.03	0.89	15.11	1.45	9.98	9.98		

sot608b po


Outline version	References				European projection	Issue date
	IEC	JEDEC	JEITA			
SOT608B						-09-08-26- 13-01-29

Fig 15. Package outline SOT608B

10. Abbreviations

Table 10. Abbreviations

Acronym	Description
CCDF	Complementary Cumulative Distribution Function
CW	Continuous Wave
LDMOS	Laterally Diffused Metal-Oxide Semiconductor
N-CDMA	Narrowband Code Division Multiple Access
PAR	Peak-to-Average power Ratio
RF	Radio Frequency
SMD	Surface Mounted Device
VSWR	Voltage Standing-Wave Ratio
WiMAX	Worldwide Interoperability for Microwave Access

11. Revision history

Table 11. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BLF6G27-45_BLF6G27S-45 v.4	20130307	Product data sheet	-	BLF6G27-45_BLF6G27S-45_3
Modifications:	• Update of Package Outline drawing.			
BLF6G27-45_BLF6G27S-45_3	20081215	Product data sheet	-	BLF6G27-45_BLF6G27S-45_2
BLF6G27-45_BLF6G27S-45_2	20080207	Preliminary data sheet		BLF6G27-45_BLF6G27S-45_1
BLF6G27-45_BLF6G27S-45_1	20080129	Preliminary data sheet		

12. Legal information

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Document status ^{[1][2]}	Product status ^[3]	Definition
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